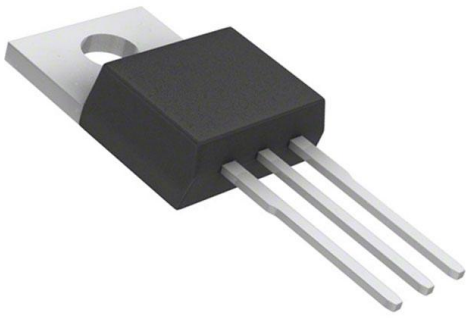


AOT462L Datasheet

www.digi-electronics.com



<https://www.DiGi-Electronics.com>

| | |
|------------------------------|---|
| DiGi Electronics Part Number | AOT462L-DG |
| Manufacturer | Alpha & Omega Semiconductor Inc. |
| Manufacturer Product Number | AOT462L |
| Description | MOSFET N-CH 60V 7A/35A TO220 |
| Detailed Description | N-Channel 60 V 7A (Ta), 35A (Tc) 2.1W (Ta), 100W (Tc) Through Hole TO-220 |



Tel: +00 852-30501935

RFQ Email: Info@DiGi-Electronics.com

DiGi is a global authorized distributor of electronic components.

Purchase and inquiry

Manufacturer Product Number:

AOT462L

Series:

-

FET Type:

N-Channel

Drain to Source Voltage (Vdss):

60 V

Drive Voltage (Max Rds On, Min Rds On):

10V

Vgs(th) (Max) @ Id:

4V @ 250µA

Vgs (Max):

±20V

FET Feature:

-

Operating Temperature:

-55°C ~ 175°C (Tj)

Supplier Device Package:

TO-220

Base Product Number:

AOT46

Manufacturer:

Alpha & Omega Semiconductor Inc.

Product Status:

Obsolete

Technology:

MOSFET (Metal Oxide)

Current - Continuous Drain (Id) @ 25°C:

7A (Ta), 35A (Tc)

Rds On (Max) @ Id, Vgs:

18mOhm @ 30A, 10V

Gate Charge (Qg) (Max) @ Vgs:

36 nC @ 10 V

Input Capacitance (Ciss) (Max) @ Vds:

2400 pF @ 30 V

Power Dissipation (Max):

2.1W (Ta), 100W (Tc)

Mounting Type:

Through Hole

Package / Case:

TO-220-3

Environmental & Export classification

RoHS Status:

ROHS3 Compliant

REACH Status:

REACH Unaffected

HTSUS:

8541.29.0095

Moisture Sensitivity Level (MSL):

1 (Unlimited)

ECCN:

EAR99



AOT462L/AOB462L

60V N-Channel MOSFET

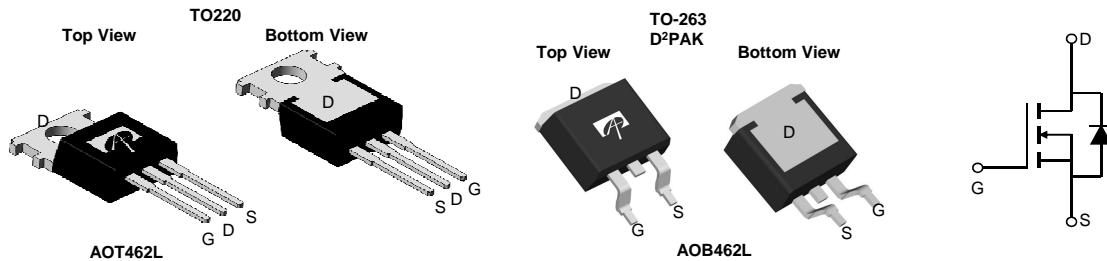
General Description

The AOT462L/AOB462L combines advanced trench MOSFET technology with a low resistance package to provide extremely low $R_{DS(ON)}$. This device is ideal for boost converters and synchronous rectifiers for consumer, telecom, industrial power supplies and LED backlighting.

Product Summary

| | |
|---------------------------------|----------------|
| V_{DS} | 60V |
| I_D (at $V_{GS}=10V$) | 35A |
| $R_{DS(ON)}$ (at $V_{GS}=10V$) | < 18m Ω |

100% UIS Tested
100% R_g Tested



Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

| Parameter | Symbol | Maximum | Units |
|--|------------------|-------------------------|------------------|
| Drain-Source Voltage | V_{DS} | 60 | V |
| Gate-Source Voltage | V_{GS} | ± 20 | V |
| Continuous Drain Current ^G | I_D | $T_C=25^\circ\text{C}$ | A |
| | | $T_C=100^\circ\text{C}$ | |
| Pulsed Drain Current ^C | I_{DM} | 120 | |
| Continuous Drain Current | I_{DSM} | $T_A=25^\circ\text{C}$ | A |
| | | $T_A=70^\circ\text{C}$ | |
| Avalanche Current ^C | I_{AS}, I_{AR} | 26 | A |
| Avalanche energy $L=0.3\text{mH}$ ^C | E_{AS}, E_{AR} | 101 | mJ |
| Power Dissipation ^B | P_D | $T_C=25^\circ\text{C}$ | W |
| | | $T_C=100^\circ\text{C}$ | |
| Power Dissipation ^A | P_{DSM} | $T_A=25^\circ\text{C}$ | W |
| | | $T_A=70^\circ\text{C}$ | |
| Junction and Storage Temperature Range | T_J, T_{STG} | -55 to 175 | $^\circ\text{C}$ |

Thermal Characteristics

| Parameter | Symbol | Typ | Max | Units |
|--|-----------------|------|-----|--------------------|
| Maximum Junction-to-Ambient ^{A,D} | $R_{\theta JA}$ | 45 | 60 | $^\circ\text{C/W}$ |
| Maximum Junction-to-Case | $R_{\theta JC}$ | 1.25 | 1.5 | $^\circ\text{C/W}$ |

Electrical Characteristics (T_J=25°C unless otherwise noted)

| Symbol | Parameter | Conditions | Min | Typ | Max | Units |
|-----------------------------|--|---|-----|--------------|------------|-------|
| STATIC PARAMETERS | | | | | | |
| BV _{DSS} | Drain-Source Breakdown Voltage | I _D =250μA, V _{GS} =0V | 60 | | | V |
| I _{DSS} | Zero Gate Voltage Drain Current | V _{DS} =60V, V _{GS} =0V T _J =55°C | | | 1 5 | μA |
| I _{GSS} | Gate-Body leakage current | V _{DS} =0V, V _{GS} =±20V | | | ±100 | nA |
| V _{GS(th)} | Gate Threshold Voltage | V _{DS} =V _{GS} I _D =250μA | 2 | 3.1 | 4 | V |
| I _{D(ON)} | On state drain current | V _{GS} =10V, V _{DS} =5V | 120 | | | A |
| R _{DS(ON)} | Static Drain-Source On-Resistance | V _{GS} =10V, I _D =30A TO220 T _J =125°C | | 14.5 25 | 18 30 | mΩ |
| | | V _{GS} =10V, I _D =30A TO263 T _J =125°C | | 14.2 24.5 | 17.7 30 | mΩ |
| | | | | | | |
| g _{FS} | Forward Transconductance | V _{DS} =5V, I _D =30A | | 50 | | S |
| V _{SD} | Diode Forward Voltage | I _S =1A, V _{GS} =0V | | 0.73 | 1 | V |
| I _S | Maximum Body-Diode Continuous Current ^G | | | | 35 | A |
| DYNAMIC PARAMETERS | | | | | | |
| C _{iss} | Input Capacitance | V _{GS} =0V, V _{DS} =30V, f=1MHz | | 1840 | 2400 | pF |
| C _{oss} | Output Capacitance | | | 185 | | pF |
| C _{rss} | Reverse Transfer Capacitance | | | 80 | | pF |
| R _g | Gate resistance | V _{GS} =0V, V _{DS} =0V, f=1MHz | | 2.8 | 4.2 | Ω |
| SWITCHING PARAMETERS | | | | | | |
| Q _{g(10V)} | Total Gate Charge | V _{GS} =10V, V _{DS} =30V, I _D =30A | | 27.8 | 36 | nC |
| Q _{gs} | Gate Source Charge | | | 9.9 | | nC |
| Q _{gd} | Gate Drain Charge | | | 6.6 | | nC |
| t _{D(on)} | Turn-On DelayTime | V _{GS} =10V, V _{DS} =30V, R _L =1Ω, R _{GEN} =3Ω | | 12 | | ns |
| t _r | Turn-On Rise Time | | | 5.2 | | ns |
| t _{D(off)} | Turn-Off DelayTime | | | 38 | | ns |
| t _f | Turn-Off Fall Time | | | 27 | | ns |
| t _{rr} | Body Diode Reverse Recovery Time | I _F =30A, dI/dt=100A/μs | | 35 | 64 | ns |
| Q _{rr} | Body Diode Reverse Recovery Charge | I _F =30A, dI/dt=100A/μs | | 47 | 62 | nC |

A. The value of R_{θJA} is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25° C. The Power dissipation P_{DSM} is based on R_{θJA} and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design, and the maximum temperature of 175° C may be used if the PCB allows it.

B. The power dissipation P_D is based on T_{J(MAX)}=175° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature T_{J(MAX)}=175° C. Ratings are based on low frequency and duty cycles to keep initial T_J=25° C.

D. The R_{θJA} is the sum of the thermal impedance from junction to case R_{θJC} and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T_{J(MAX)}=175° C. The SOA curve provides a single pulse rating.

G. The maximum current limited by package.

H. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25° C.

THIS PRODUCT HAS BEEN DESIGNED AND QUALIFIED FOR THE CONSUMER MARKET. APPLICATIONS OR USES AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS ARE NOT AUTHORIZED. AOS DOES NOT ASSUME ANY LIABILITY ARISING OUT OF SUCH APPLICATIONS OR USES OF ITS PRODUCTS. AOS RESERVES THE RIGHT TO IMPROVE PRODUCT DESIGN, FUNCTIONS AND RELIABILITY WITHOUT NOTICE.

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

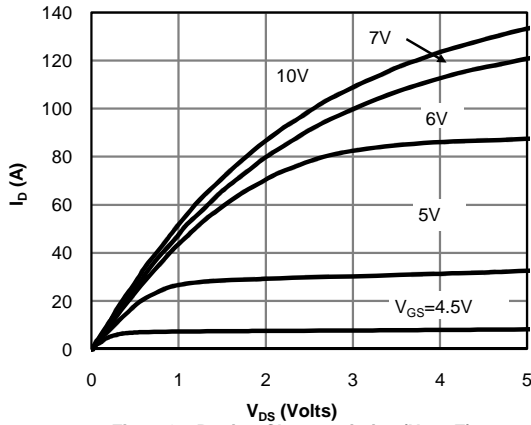


Fig 1: On-Region Characteristics (Note E)

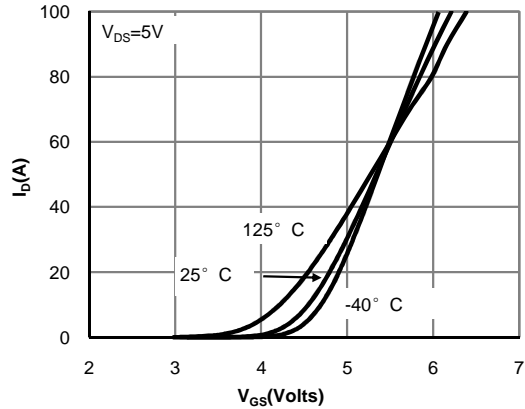


Figure 2: Transfer Characteristics (Note E)

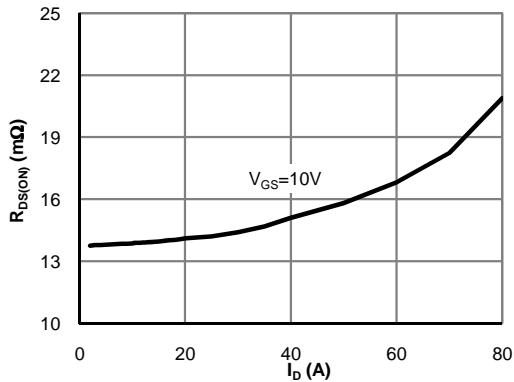


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

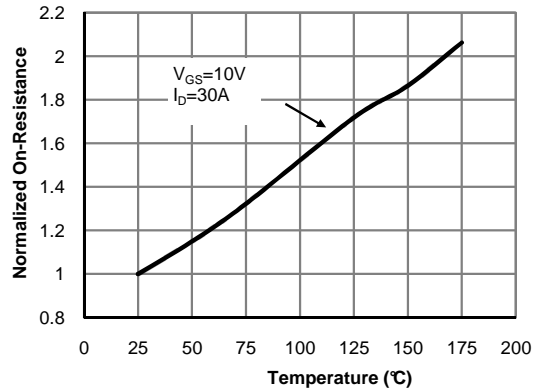


Figure 4: On-Resistance vs. Junction Temperature (Note E)

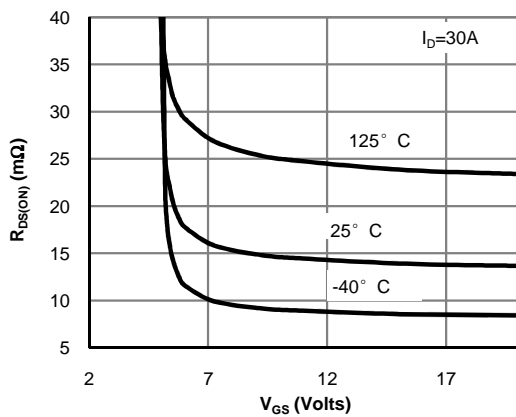


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

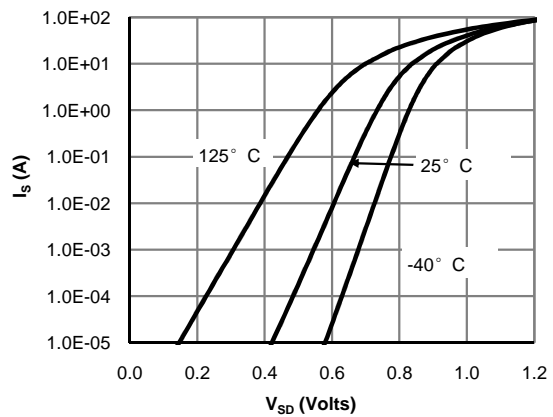


Figure 6: Body-Diode Characteristics (Note E)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

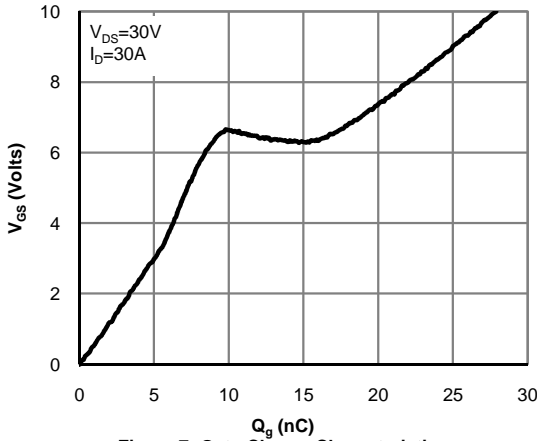


Figure 7: Gate-Charge Characteristics

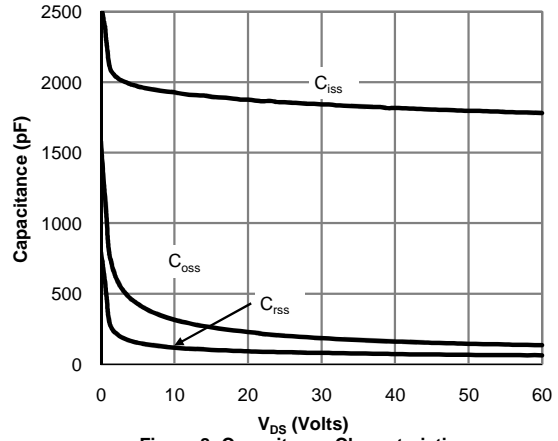


Figure 8: Capacitance Characteristics

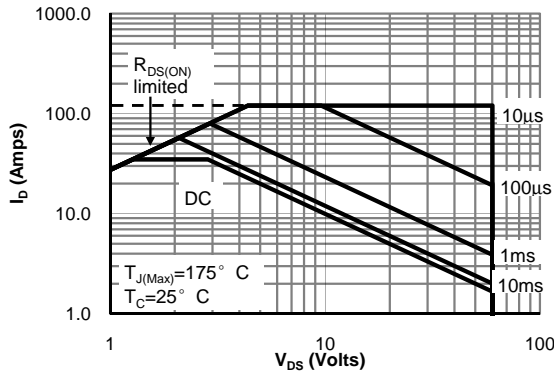


Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

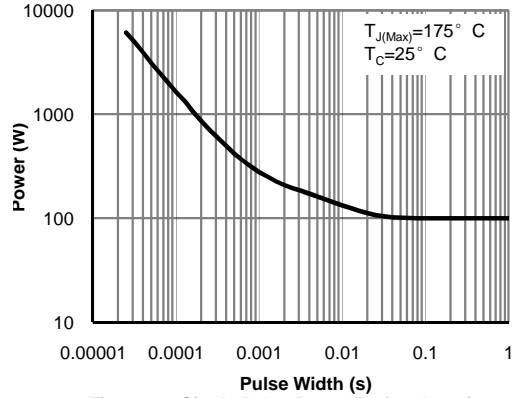


Figure 10: Single Pulse Power Rating Junction-to-Case (Note F)

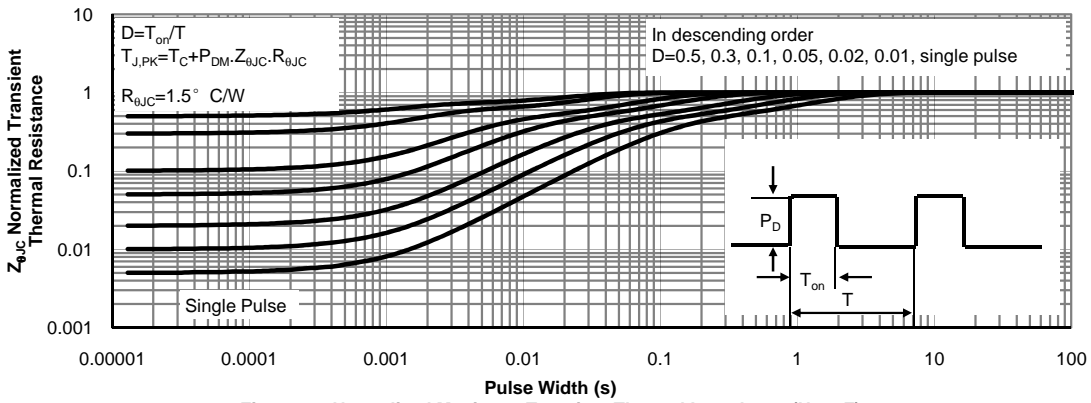


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

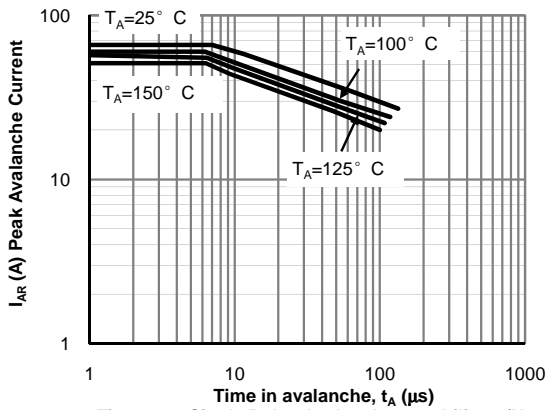


Figure 12: Single Pulse Avalanche capability (Note C)

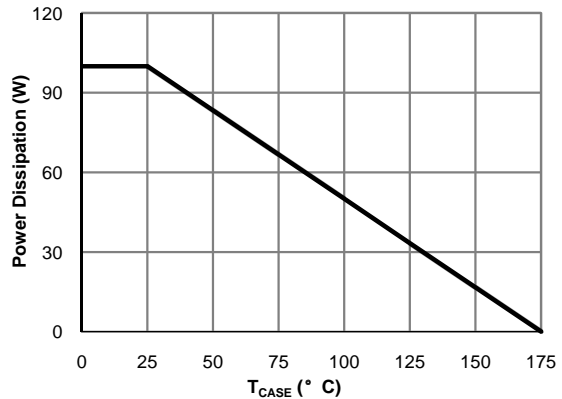


Figure 13: Power De-rating (Note F)

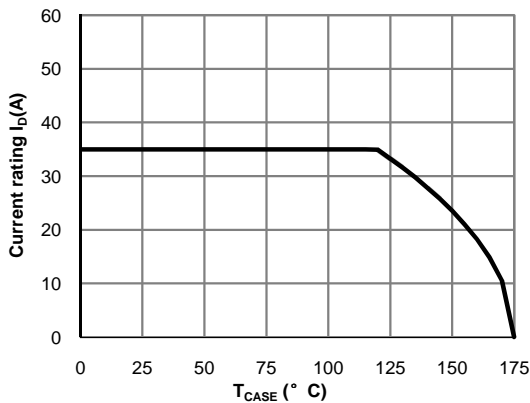


Figure 14: Current De-rating (Note F)

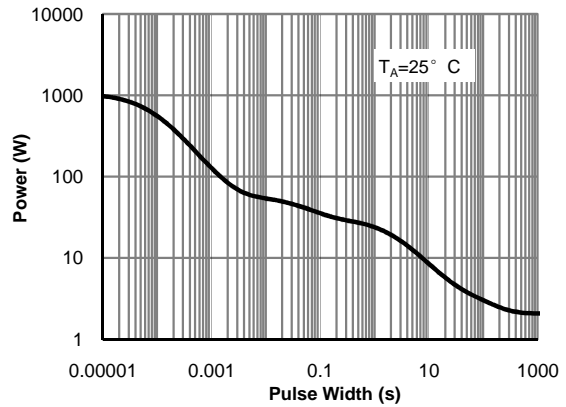


Figure 15: Single Pulse Power Rating Junction-to-Ambient (Note H)

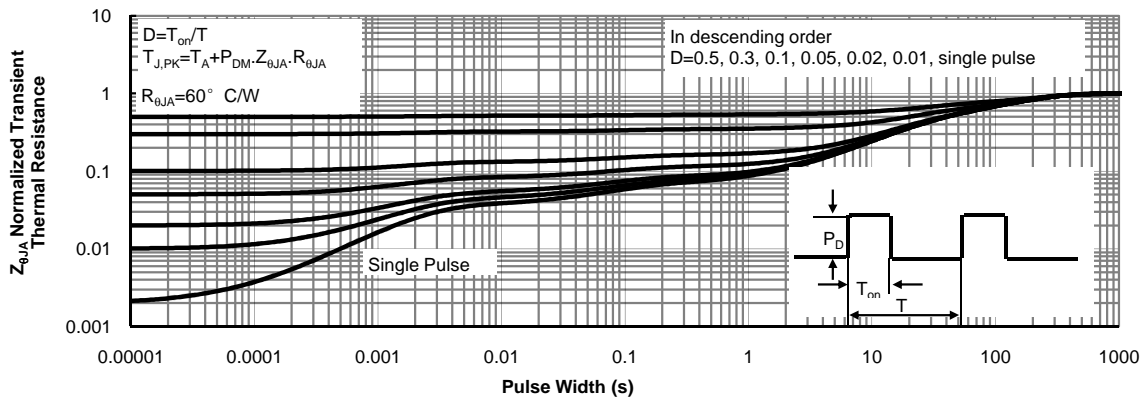
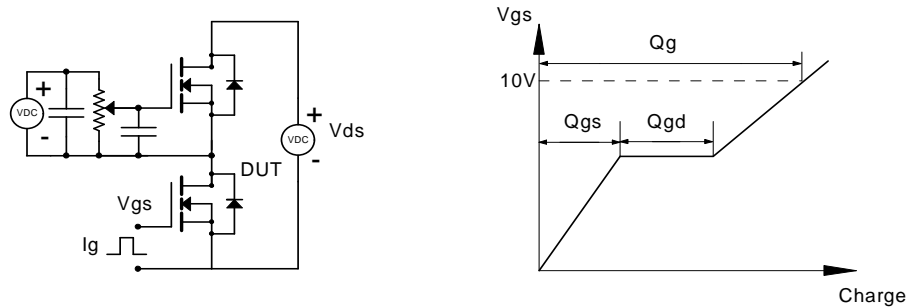
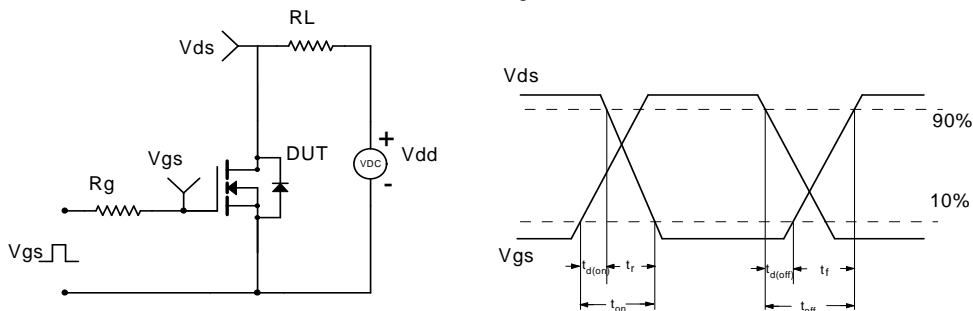


Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)

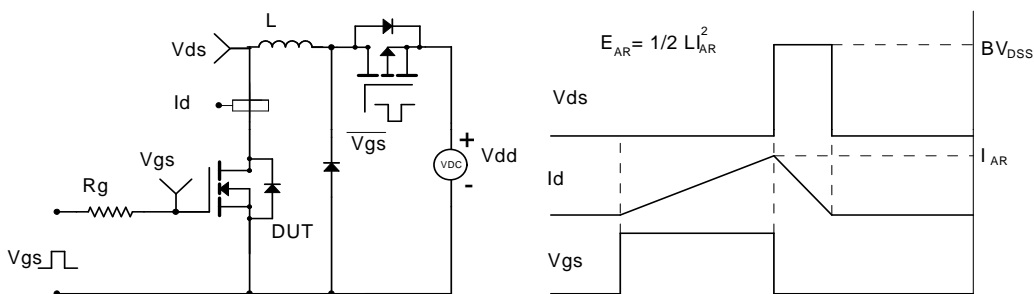
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms

